


<b>Search Notes</b>  	<b>Application/Control No.</b>  10653825	<b>Applicant(s)/Patent Under Reexamination</b>  WONG ET AL.
	<b>Examiner</b>  Chawan, Sheela C	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	141, 145	9/23/07	SCC
359	798,831	9/23/07	SCC
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SEARCH NOTES		
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SEARCH EAST AND OTHER DATA BASE , SEE THE ATTACHED SEARCH SHEET.	9/24/07	SCC
INVENTOR NAME SEARCH.	9/24/07	SCC
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ONLY, SEE TEXT SEARCH .		
359/798, 831.CCLS. "	9/24/07	SCC
INTERFERENCE SEARCH , SEE SEARCH HISTORY PRINT OUT.	9/24/07	SCC
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INTERFERENCE SEARCH			
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382	141, 145	9/24/07	SCC
359	798,831	9/24/07	SCC